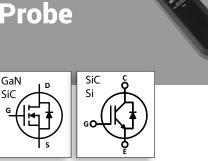


# DL-ISO High Voltage Optically Isolated Probe





- 1 GHz bandwidth
- Ideal for GaN and SiC devices
- 1.5% system accuracy
- 435 ps rise time
- High CMRR 160 dB
- Flexible connectivity options
- Autozero without disconnection

### **Key Applications**

- Servers
- Motherboards
- Mobiles
- Lighting and building automation
- Residential inverters
- UPS
- Switch Mode Power Supplies
- Motors in household and commercial appliances

The DL-ISO enables highest confidence in GaN and SiC device characterization with highest accuracy, best signal fidelity, and comprehensive connectivity.

### **Best Probe for GaN and SiC**

With 1 GHz of bandwidth, 2500 V differential input range, and 60 kV common mode, DL-ISO probes are perfect for both GaN and SiC device characterization and system development engineers.

### **Highest Accuracy**

Combine DL-ISO probes with industry-leading 12-bit resolution High Definition Oscilloscopes (HDOs) to get 1.5% system accuracy, nearly twice as good as the alternate solution in the market.

### **Best Signal Fidelity**

During measurements, getting the most faithful representation of the signal can be elusive. DL-ISO overcomes that challenge by delivering the industry's best signal fidelity with the fastest rise time, lowest overshoot, and low DUT loading.

**ADMESS** 

## **Comprehensive Connectivity**

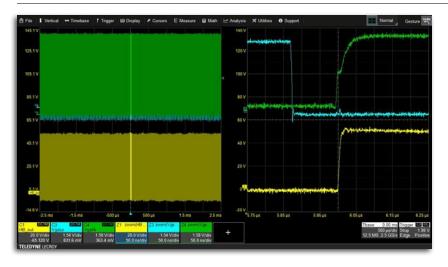
DL-ISO probes increase measurement confidence by employing high-quality coaxial attenuating tips that reject unwanted noise and terminate into test boards using industry standard MMCX connectors or high-voltage safe square pin headers.

# MOST ACCURATE GAN AND SIC CHARACTERIZATION



### **Highest Accuracy**

- Best system accuracy 1.5%
- High 160 dB CMRR for superior noise rejection
- Precision Gain Calibration on 12-bit High Definition Oscilloscopes gives best results



### **Best Signal Fidelity**

- Most faithful representation of the signal
- Low probe loading and minimal overshoot
- Fastest rise times (435 ps) ideal for capturing high dV/dt GaN and SiC waveforms



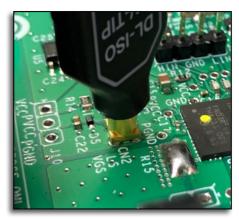
# **Comprehensive Connectivity**

- Easily interface with test boards using industry standard MMCX connectors
- Safely connect to 1000 and 2500 V using compatible square pin headers
- Improve EMI/RF immunity and reduce stray noise pickup with high-quality coaxial leads

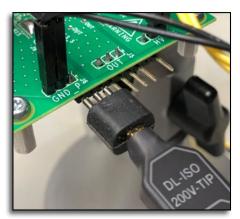
# HIGHEST CONFIDENCE FOR WIDE BANDGAP MEASUREMENTS



DL-ISO with flexible interfaces to DUTs



MMCX connector for measuring gate-drive signals



Square pin header for safe high-voltage measurement



### Flexible In-Circuit Debug

- All purpose probe for DC bus, device (Vgs & Vds), and inverter output measurements
- Large common-mode and wide differential swing to handle very large DC bus voltages
- Device-Power software automatically calculates various device losses as defined by JEDEC®

### **Interested In More Power Electronic Probes?**

### **Lower Voltage GaN Measurement**

With 60 V of common mode, 80 V of differential input range, and 1 GHz of bandwidth, DL-HCM probes provide the bandwidth and performance necessary for testing various low-power GaN systems.



### Compact, Simple, Affordable

With 150 MHz of bandwidth, the HVF0108 fits into tight spaces as well as tight budgets without sacrificing performance.



# SPECIFICATIONS AND ORDERING INFORMATION

| Electrical                     | DL03-ISO   | DL07-ISO  | DL10-ISO                           |
|--------------------------------|--|---|------------------------------------|
| Bandwidth                      | 350 MHz  | 700 MHz   | 1 GHz                              |
| Rise Time (10-90%)             | 1.1 ns   | 575 ps  | 435 ps                             |
| Differential Voltage Range     | 2 V to 2500 V with different attenuating   | g tips  |                                    |
| (Pk to Pk)                     |  |   |                                    |
| Common Mode Voltage Range      | ±60 kV (DC+Peak AC) (not for hand-hel  | d use, with adequate spacing between                          | probe components and earth ground) |
| Maximum Input Voltage to Earth | ±60 kV (DC+Peak AC) (not for hand-he   | ld use, with adequate spacing between                         | probe components and earth ground) |
| Maximum Non-destruct Voltage   |  | <b>DL-ISO-10V-TIP:</b> 100 V                                  |                                    |
| (DC+Peak AC)                   | <b>DL-ISO-40V-TIP:</b> 250 V   | <b>DL-ISO-200V-TIP:</b> 300 V                                 |                                    |
| Sensitivity                    | <b>DL-ISO-2V-TIP:</b> 20 mV/div to 250 mV <b>DL-ISO-40V-TIP:</b> 400 mV/div to 5 V/div |   | //div to 1.3 V/div<br>to 25 V/div  |
| DC Gain Accuracy               | 1.5% (after Precision Gain Calibration)  |   |                                    |
| DC Gain Drift                  | < 1 %/°C   |   |                                    |
| Offset                         | <b>DL-ISO-2V-TIP:</b> ±25 V <b>DL-ISO-40V-TIP:</b> ±150 V                              | <b>DL-ISO-10V-TIP:</b> ±50 V <b>DL-ISO-200V-TIP:</b> ±150 V   | _                                  |
| Input Impedance                | <b>DL-ISO-2V-TIP:</b> 200 kΩ    3.6 pF <b>DL-ISO-40V-TIP:</b> 1 MΩ    2.1 pF           | <b>DL-ISO-10V-TIP:</b> 1 MΩ    <b>DL-ISO-200V-TIP:</b> 7.5 MΩ |                                    |
| Output Termination             | 50 Ω   |   |                                    |
| Input/Output Coupling          | DC only  |   |                                    |
| Interface                      | ProBus   |   |                                    |
| Cable Length                   | 3.375 m (11 feet) from probe tip to osci   | illoscope connection  |                                    |

#### Noise, Rejection, and Electromagnetic Compatibility (EMC)

| Noise, Rejection, and Electromagnetic Compatibility (EWC) |            |            |                 |                |        |        |         |         |         |       |
|---|------------|------------|-----------------|----------------|--------|--------|---------|---------|---------|-------|
| Noise   |            |            |                 | CMRR           |        |        |         |         |         |       |
| DL-ISO-2V-TIP   | 1 GHz      | 700 MHz    | 350 MHz         | Probe Tip      | DC     | 1 MHz  | 100 MHz | 200 MHz | 500 MHz | 1 GHz |
| 50 mV/div   | 1.98 mVrms | 1.78 mVrms | 1.12 mVrms      | DL-ISO-2V-TIP  | 160 dB | 110 dB | 90 dB   | 90 dB   | 80 dB   | 75 dB |
| 100 mV/div  | 3.37 mVrms | 3.00 mVrms | 2.25 mVrms      | DL-ISO-10V-TIP | 160 dB | 100 dB | 75 dB   | 75 dB   | 65 dB   | 65 dB |
| 200 mV/div  | 9.22 mVrms | 7.12 mVrms | 4.49 mVrms      | DL-ISO-40V-TIP | 150 dB | 100 dB | 70 dB   | 60 dB   | 60 dB   | 50 dB |
| Noise scales proportional to 2 V tip voltage capability   |            |            | DL-ISO-200V-TIP | 140 dB         | 95 dB  | 55 dB  | 50 dB   | 45 dB   | 35 dB   |       |
| 10 V tip noise will be 10/2 = 5x of 2 V tip               |            |            |                 |                |        |        |         |         |         |       |

| Electrostatic Discharge (ESD)<br>Immunity              | 8 kV contact discharge and 10 kV air discharge per IEC61000-4-2, criteria A  |
|--|--|
| Radiated RF Electromagnetic Field Immunity             | Up to 25 V/m (80 MHz to 2.7 GHz) per IEC61000-4-3, criteria A when operating in standard configuration   |
| Immunity to Conducted Disturbance Induced by RF Fields | Up to 10 V (150 kHz to 80 MHz) per IEC61000-4-6, criteria A when operating in standard configuration   |
| Environmental  |  |
| Temperature  | 5°C to 40°C (operating in standard configuration), -20°C to 70°C (non-operating)   |
| Humidity   | 5% to 95% RH (non-condensing), 75% RH above 30°C, 45% RH above 40°C  |
| Altitude   | Up to 3000 m (operating), 10,000 m (non-operating)   |
| Pollution Degree                                       | 2, Indoor Use Only   |
| Certifications   |  |
| CE Declaration of Conformity                           | Low Voltage Directive 2014/35/EU (IEC/EN 61010-1:2010; IEC/EN 61010-2-030:2010)<br>EMC Directive 2014/30/EU (IEC/EN 61326-1:2013; IEC/EN 61326-2-1:2013)<br>RoHS2 Directive 2011/65/EU (IEC/EN 63000:2018) |
| Laser Product certifications                           | IEC/EN 60825-1:2014; US 21CFR Part 1010; US 21CFR Part 1040  |

### **Ordering Information**

| Product Description                                      | <b>Product Code</b> |  |  |  |  |
|--|---------------------|--|--|--|--|
| <b>High Voltage Optically Isolated Probe Models</b>      |                     |  |  |  |  |
| High Voltage Optically Isolated Probe, 350 MHz Bandwidth | DL03-ISO            |  |  |  |  |
| High Voltage Optically Isolated Probe, 700 MHz Bandwidth | DL07-ISO            |  |  |  |  |
| High Voltage Optically Isolated Probe, 1 GHz Bandwidth   | DL10-ISO            |  |  |  |  |
| Accessories (must be ordered separately)                 |                     |  |  |  |  |
| DL-ISO 2 V MMCX Tip                                      | DL-ISO-2V-TIP       |  |  |  |  |
| DL-ISO 10 V MMCX Tip                                     | DL-ISO-10V-TIP      |  |  |  |  |
| DL-ISO 40 V MMCX Tip                                     | DL-ISO-40V-TIP      |  |  |  |  |
| DL-ISO 200 V MMCX Tip                                    | DL-ISO-200V-TIP     |  |  |  |  |
| DL-ISO MMCX to high-voltage 0.1" square pin adapter      | DL-ISO-M2S          |  |  |  |  |
| DL-ISO 1000/2500 V high-voltage 0.2" square pin Tip      | Coming soon         |  |  |  |  |

For more information, please contact:



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E-Mail: info@admess.de www.admess.de

#### **Customer Service**

Teledyne LeCroy oscilloscopes and probes are designed, built, and tested to ensure high reliability. In the unlikely event you experience difficulties, our digital oscilloscopes are fully warranted for three years and our probes are warranted for one year. This warranty includes:

No charge for return shipping
 Long-term 7-year support
 Upgrade to latest software at no charge



1-800-5-LeCroy teledynelecroy.com

Local sales offices are located throughout the world. Visit our website to find the most convenient location.